

<b>Notice of References Cited</b>	Application/Control No. 10/551,839		Applicant(s)/Patent Under Reexamination NOZUE ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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#### FOREIGN PATENT DOCUMENTS

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	N	JP 2000336696 A	12-2000	Japan	MAEZAWA et al.	E02F009/12
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#### NON-PATENT DOCUMENTS

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